MB39A214A is a N -ch/ N-ch synchronous rectification type 2ch Buck DC/DC converter IC equipped with a bottom detection comparator for low output voltage ripple. It supports low on-duty operation to allow stable output of low voltages when there is a large difference between input and output voltages. It also allows the high switching frequency setting, enabling the downsized peripheral circuits and low-cost configuration. MB39A214A realizes ultra-rapid response and high efficiency with built-in enhanced protection features. It is most suitable for the power supply for ASIC or FPGA core, input/output devices, or memory.
Features

- High efficiency
■Frequency setting by internal preset function: $310 \mathrm{kHz}, 620 \mathrm{kHz}, 1 \mathrm{MHz}$
■High accuracy reference voltage $\pm 0.7 \%\left(\mathrm{Ta}=+25^{\circ} \mathrm{C}\right)$
■VIN Input voltage range ..... : 6 V to 28 V
■Output voltage setting range - 0.7 V to 5.3 V
■Possible to select the automatic PFM/PWM selection mode or PWM-fixed mode
■PAF frequency limitation function (Prohibit Audio Frequency) : > 30 kHz (Min)
■Built-in boost diode, external fly-back diode not required
■Built-in discharge FET
-Built-in over voltage protection function
■Built-in under voltage protection function
■Built-in over temperature protection function
■Built-in over current limitation function
-Soft-start circuit without load dependence
■ Current sense resistor not required
■uilt-in synchronous rectification type output steps for N-ch MOS FET
- Standby current

$$
\text { : } 0 \mu \mathrm{~A} \text { (Тур) }
$$

- Package


## Applications

- Digital TV

■ Photocopiers
■STB
■BD, DVD players/recorders
■ Projectors etc.

MB39A214A

## Contents

1. Pin Assignment ..... 3
2. Pin Descriptions ..... 4
3. Block Diagram ..... 5
4. Absolute Maximum Ratings ..... 6
5. Recommended Operating Conditions ..... 7
6. Electrical Characteristics ..... 8
7. Typical Characteristics ..... 11
8. Function ..... 14
9. I/O Pin Equivalent Circuit Diagram ..... 23
10. Example Application Circuit ..... 25
11. Part List ..... 26
12. Application Note ..... 27
12.1 Setting Operating Conditions ..... 27
12.2 Selecting parts ..... 33
13. Reference Data ..... 43
14. Usage Precaution ..... 47
15. Ordering Information ..... 48
16. EV Board Ordering Information ..... 48
17. RoHS Compliance Information Of Lead (Pb) Free Version ..... 48
18. Marking Format (Lead Free Version), ..... 48
19. Labeling Sample (Lead free version) ..... 49
20. MB39A214APFT Recommended Conditions of Moisture Sensitivity Level ..... 50
21. Package Dimensions ..... 52
22. Major Changes ..... 53
Document History ..... 54

MB39A214A
Embedded in Tomorrow ${ }^{*}$

## 1. Pin Assignment

(TOP VIEW)

(FPT-24P-M09)

MB39A214A
Embedded in Tomorrow ${ }^{-}$

## 2. Pin Descriptions

| Pin No. | Pin Name | I/O | Description |
| :---: | :---: | :---: | :---: |
| 1 | BST1 | - | CH1 boost capacitor connection pin. |
| 2 | EN1 | I | CH1 enable pin. |
| 3 | VOUT1 | 1 | CH1 input pin for DC/DC output voltage. |
| 4 | FB1 | 1 | CH1 input pin for feedback voltage. |
| 5 | CS1 | I | CH1 soft-start time setting capacitor connection pin. |
| 6 | GND | - | Ground pin. |
| 7 | FREQ | 1 | Frequency switching signal input pin.   <br> FREQ: GND Short Switching frequency 310 kHz <br> FREQ: Open Switching frequency 620 kHz <br> FREQ: VB Short Switching frequency 1 MHz |
| 8 | CS2 | 1 | CH2 soft-start time setting capacitor connection pin. |
| 9 | FB2 | 1 | CH2 input pin for feedback voltage. |
| 10 | VOUT2 | 1 | CH2 input pin for DC/DC output voltage. |
| 11 | EN2 | 1 | CH2 enable pin. |
| 12 | BST2 | - | CH 2 boost capacitor connection pin. |
| 13 | DRVH2 | 0 | CH2 output pin for external high-side FET gate drive. |
| 14 | LX2 | - | CH 2 inductor and external high-side FET source connection pin. |
| 15 | DRVL2 | - | CH2 output pin for external low-side FET gate drive. |
| 16 | ILIM2 | I | CH2 over current detection level setting voltage input pin. |
| 17 | MODE | 1 | DC/DC control mode switching signal input pin. <br> MODE: GND Short PFM/PWM <br> MODE: Open PFM/PWM, PAF <br> MODE: VB Short PWM fixed |
| 18 | VB | 0 | Internal circuit bias output pin. |
| 19 | VCC | 1 | Power input pin for control and output circuits. |
| 20 | ILIM1 | 1 | CH1 over current detection level setting voltage input pin. |
| 21 | PGND | - | Ground pin for output circuit. |
| 22 | DRVL1 | 0 | CH1 output pin for external low-side FET gate drive. |
| 23 | LX1 | - | CH1 inductor and external high-side FET source connection pin. |
| 24 | DRVH1 | 0 | CH1 output pin for external high-side FET gate drive. |

## 3. Block Diagram



MB39A214A
Embedded in Tomorrow

## 4. Absolute Maximum Ratings

| Parameter | Symbol | Condition | Rating |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Max |  |
| VCC pin input voltage | $\mathrm{V}_{\mathrm{vcc}}$ | VCC pin | -0.3 | +30 | V |
| BST pin input voltage | $\mathrm{V}_{\text {BST }}$ | BST1, BST2 pins | -0.3 | +36 | V |
| LX pin input voltage | $V_{L X}$ | LX1, LX2 pins | -1 | + 30 | V |
| Voltage between BST and LX | $\mathrm{V}_{\text {BST-LX }}$ | - | -0.3 | + 7 | V |
| EN pin input voltage | $\mathrm{V}_{\text {EN }}$ | EN1, EN2 pins | -0.3 | + 30 | V |
| Input voltage | $\mathrm{V}_{\text {FB }}$ | FB1, FB2 pins | -0.3 | VB + 0.3 | V |
|  | $\mathrm{V}_{\text {Vout }}$ | VOUT1, VOUT2 pins | -0.3 | + 7 | V |
|  | $\mathrm{V}_{\text {ILIM }}$ | ILIM1, ILIM2 pins | -0.3 | VB + 0.3 | V |
|  | $\mathrm{V}_{\text {cs }}$ | CS1, CS2 pins | -0.3 | $\mathrm{VB}+0.3$ | V |
|  | $\mathrm{V}_{\text {FREQ }}$ | FREQ pin | -0.3 | $\mathrm{VB}+0.3$ | V |
|  | $\mathrm{V}_{\text {MODE }}$ | MODE pin | -0.3 | VB + 0.3 | V |
| Output current | lout | DRVH1, DRVH2 pins, DRVL1, DRVL2 pins | - | 60 | mA |
| Power dissipation | PD | $\mathrm{Ta} \leq+25^{\circ} \mathrm{C}$ | - | + 1282 | mW |
| Storage temperature | $\mathrm{T}_{\text {STG }}$ | - | - 55 | + 125 | ${ }^{\circ} \mathrm{C}$ |

## WARNING:

Semiconductor devices can be permanently damaged by application of stress (voltage, current, temperature, etc.) in excess of absolute maximum ratings. Do not exceed these ratings.

## 5. Recommended Operating Conditions

| Parameter | Symbol | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | Min | Typ | Max |  |
| VCC pin input voltage | $\mathrm{V}_{\mathrm{vcc}}$ | VCC pin | 6 | - | 28 | V |
| BST pin input voltage | $\mathrm{V}_{\text {BST }}$ | BST1, BST2 pins | - | - | 34 | V |
| EN pin input voltage | $\mathrm{V}_{\text {EN }}$ | EN1, EN2 pins | 0 | - | 28 | V |
| Input voltage | $\mathrm{V}_{\text {FB }}$ | FB1, FB2 pins | 0 | - | VB | V |
|  | $V_{\text {vout }}$ | VOUT1, VOUT2 pins | 0 | - | 5.5 | V |
|  | $\mathrm{V}_{\text {ILIM }}$ | ILIM1, ILIM2 pins | 0 | - | 2 | V |
|  | $\mathrm{V}_{\text {FREQ }}$ | FREQ pin | 0 | - | VB | V |
|  | $\mathrm{V}_{\text {MODE }}$ | MODE pin | 0 | - | VB | V |
| Peak output current | lout | DRVH1, DRVH2 pins, DRVL1, DRVL2 pins $\text { Duty } \leq 5 \%(t=1 / \text { fosc } \times \text { Duty })$ | - 1200 | - | + 1200 | mA |
| Operating ambient temperature | Ta | - | - 30 | + 25 | + 85 | ${ }^{\circ} \mathrm{C}$ |

## WARNING:

The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.
Always use semiconductor devices within their recommended operating condition ranges.
Operation outside these ranges may adversely affect reliability and could result in device failure.
No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet.
Users considering application outside the listed conditions are advised to contact their representatives beforehand.

## 6. Electrical Characteristics

$\left(\mathrm{Ta}=+25^{\circ} \mathrm{C}, \mathrm{VCC}=12 \mathrm{~V}, \mathrm{EN} 1, \mathrm{EN} 2=5 \mathrm{~V}\right)$

| Parameter |  | Symbol | Pin No. | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min |  |  | Typ | Max |  |
| Bias Voltage Block [VB Reg.] | Output voltage |  | $\mathrm{V}_{\mathrm{VB}}$ | 18 | $V B=0 \mathrm{~A}$ | 5.04 | 5.20 | 5.36 | V |
|  | Input stability | LINE | 18 | $\mathrm{VCC}=6 \mathrm{~V}$ to 28 V | - | 10 | 100 | mV |
|  | Load stability | LOAD | 18 | $\mathrm{VB}=0 \mathrm{~A}$ to -1 mA | - | 10 | 100 | mV |
|  | Short-circuit output current | los | 18 | $\mathrm{VB}=0 \mathrm{~V}$ | - 145 | - 100 | - 75 | mA |
| Under voltage Lockout Protection Circuit Block [UVLO] | Threshold voltage | $\mathrm{V}_{\text {TLH }}$ | 18 | VB pin | 4.0 | 4.3 | 4.6 | V |
|  |  | $\mathrm{V}_{\text {THL }}$ | 18 | VB pin | 3.7 | 4.0 | 4.3 | V |
|  | Hysteresis width | $\mathrm{V}_{\mathrm{H}}$ | 18 | VB pin | - | $0.3^{[1]}$ | - | V |
| Soft-Start/ Discharge Block [Soft Start, Discharge] | Charge current | Ics | 5,8 | CS1, CS2 = 0 V | -1.5 | -1.0 | -0.75 | $\mu \mathrm{A}$ |
|  | Electrical discharge resistance | R ${ }_{\text {D }}$ | 3,10 | $\begin{aligned} & \text { EN1, EN2 = } 0 \mathrm{~V}, \\ & \text { VOUT1, VOUT2 } \geq 0.15 \mathrm{~V} \end{aligned}$ | - | $25^{[1]}$ | - | $\Omega$ |
|  | Discharge end voltage | $V_{\text {vovth }}$ | 3,10 | EN1, EN2 = 0 V, VOUT1, VOUT2 pins | - | $0.2^{[1]}$ | - | V |
| ON/OFF Time <br> Generator <br> Block <br> [ton <br> Generator] | ON time (Preset value 1) | ton11 | 24 | FREQ pin GND connection VCC $=12 \mathrm{~V}$, $\mathrm{VOUT} 1=1.5 \mathrm{~V}$ | 430 | 538 | 646 | ns |
|  |  | ton21 | 13 | FREQ pin GND connection $\mathrm{VCC}=12 \mathrm{~V}, \mathrm{VOUT} 2=1.5 \mathrm{~V}$ | 320 | 400 | 480 | ns |
|  | ON time (Preset value 2) | ton12 | 24 | FREQ pin OPEN VCC $=12 \mathrm{~V}$, VOUT1 $=1.5 \mathrm{~V}$ | 210 | 263 | 316 | ns |
|  |  | ton22 | 13 | $\begin{aligned} & \text { FREQ pin OPEN } \\ & \mathrm{VCC}=12 \mathrm{~V}, \mathrm{VOUT} 2=1.5 \mathrm{~V} \end{aligned}$ | 160 | 200 | 240 | ns |
|  | ON time (Preset value 3) | ton13 | 24 | FREQ pin VB connection VCC $=12 \mathrm{~V}, \mathrm{VOUT} 1=1.5 \mathrm{~V}$ | 130 | 163 | 196 | ns |
|  |  | ton23 | 13 | FREQ pin VB connection $\mathrm{VCC}=12 \mathrm{~V}$, VOUT2 $=1.5 \mathrm{~V}$ | 100 | 125 | 150 | ns |
|  | Minimum ON time (Preset value 1) | tonmin11 | 24 | FREQ pin GND connection $\mathrm{VCC}=12 \mathrm{~V}, \mathrm{VOUT} 1=0 \mathrm{~V}$ | - | 136 | 191 | ns |
|  |  | tonmin21 | 13 | FREQ pin GND connection $\mathrm{VCC}=12 \mathrm{~V}, \mathrm{VOUT} 2=0 \mathrm{~V}$ | - | 103 | 145 | ns |
|  | Minimum ON time (Preset value 2) | tonmin12 | 24 | FREQ pin OPEN $\mathrm{VCC}=12 \mathrm{~V}, \mathrm{VOUT} 1=0 \mathrm{~V}$ | - | 77 | 108 | ns |
|  |  | tonmin22 | 13 | $\begin{aligned} & \text { FREQ pin OPEN } \\ & \text { VCC }=12 \mathrm{~V}, \mathrm{VOUT} 2=0 \mathrm{~V} \end{aligned}$ | - | 58 | 82 | ns |
|  | Minimum ON time (Preset value 3) | tonmini3 | 24 | FREQ pin VB connection VCC $=12 \mathrm{~V}, \mathrm{VOUT} 1=0 \mathrm{~V}$ | - | 55 | 77 | ns |
|  |  | tonmin23 | 13 | FREQ pin VB connection $\mathrm{VCC}=12 \mathrm{~V}$, VOUT2 $=0 \mathrm{~V}$ | - | 43 | 61 | ns |
|  | Minimum OFF time | toffmin | 24,13 | - | - | 410 | 535 | ns |


| Parameter |  | Symbol | Pin No. | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min |  |  | Typ | Max |  |
| Error Comparison Block [Error Comp.] | Threshold voltage |  | $\mathrm{V}_{\text {TH }}$ | 4, 9 | $\mathrm{Ta}=+25^{\circ} \mathrm{C}$ | 0.695 | 0.700 | 0.705 | V |
|  | FB pin input current | $\mathrm{I}_{\text {FB }}$ | 4, 9 | FB1, FB2 $=0.7 \mathrm{~V}$ | -0.1 | 0 | +0.1 | $\mu \mathrm{A}$ |
|  | VOUT pin input current | Ivo | 3,10 | VOUT1, VOUT2 $=1.5 \mathrm{~V}$ | - | 6.0 | 8.6 | $\mu \mathrm{A}$ |
| Over Current Detection Block [ILIM Comp.] | Over current detection offset voltage | $\mathrm{V}_{\text {OFFILIM }}$ | $\begin{aligned} & 21 \text { to } 23 \\ & 21 \text { to } 14 \end{aligned}$ | $\begin{aligned} & \text { PGND - LX1, LX2 } \\ & \text { ILIM1, ILIM2 = } 500 \mathrm{mV} \end{aligned}$ | - 30 | 0 | +30 | mV |
|  | ILIM pin current | IILIM | 20,16 | ILIM1, ILIM2 = 0 V | -6 | -5 | -4 | $\mu \mathrm{A}$ |
|  | ILIM pin current Temperature slope | TILIM | 20,16 | $\mathrm{Ta}=+25^{\circ} \mathrm{C}$ | - | $4500{ }^{[1]}$ | - | $\begin{array}{\|l\|} \hline \text { ppm/ } \\ { }^{\circ} \mathrm{C} \end{array}$ |
| Overvoltage Protection Circuit Block [OVP Comp.] | Over-voltage detecting voltage | Vovp | 4,9 | For REF1, REF2 voltage | 110 | 115 | 120 | \% |
|  | Hysteresis width | $\mathrm{V}_{\text {Hovp }}$ | 4,9 | - | - | $5^{[1]}$ | - | \% |
|  | Detection delay time | tovp | - | - | 10 | 15 | 20 | $\mu \mathrm{S}$ |
| Undervoltage Protection Circuit Block [UVP Comp.] | Under-voltage detecting voltage | Vuvp | 4,9 | For REF1, REF2 voltage | 65 | 70 | 75 | \% |
|  | Hysteresis width | $\mathrm{V}_{\text {HUVP }}$ | 4,9 | - | - | $10^{[1]}$ | - | \% |
|  | Detection delay time | tuvp | - | - | 100 | 150 | 200 | $\mu \mathrm{s}$ |
| Overtemperature Protection Circuit Block [OTP] | Protection temperature | TOTPH | - | - | - | $150{ }^{[1]}$ | - | ${ }^{\circ} \mathrm{C}$ |
|  |  | Totpl | - | - | - | $125^{[1]}$ | - | ${ }^{\circ} \mathrm{C}$ |
| Output Block [DRV] | High-side output on-resistance | Roн | 24,13 | DRVH1, DRVH2 = - 100 mA | - | 4 | 6 | $\Omega$ |
|  |  | RoL | 24,13 | DRVH1, DRVH2 = 100 mA | - | 1 | 1.5 | $\Omega$ |
|  | Low-side output on-resistance | ROH | 22,15 | DRVL1, DRVL2 $=-100 \mathrm{~mA}$ | - | 4 | 6 | $\Omega$ |
|  |  | RoL | 22,15 | DRVL1, DRVL2 $=100 \mathrm{~mA}$ | - | 1 | 1.5 | $\Omega$ |
|  | Output source current | Isource | $\begin{aligned} & 24,13 \\ & 22,15 \end{aligned}$ | $\begin{aligned} & \text { LX1, LX2 = } 0 \mathrm{~V}, \\ & \text { BST1, BST2 = VB } \\ & \text { DRVH1, DRVH2 = } 2.5 \mathrm{~V} \\ & \text { Duty } \leq 5 \% \end{aligned}$ | - | $-0.5{ }^{[1]}$ | - | A |
|  | Output sink current | Isink | $\begin{array}{r} 24,13 \\ 22,15 \end{array}$ | $\begin{array}{\|l} \hline \text { LX1, LX2 }=0 \mathrm{~V}, \\ \text { BST1, BST2 }=\text { VB } \\ \text { DRVH1, DRVH2 }=2.5 \mathrm{~V} \\ \text { Duty } \leq 5 \% \\ \hline \end{array}$ | - | $0.9{ }^{[1]}$ | - | A |
|  | Dead time | $t_{D}$ | $\begin{aligned} & 24 \text { to } 22 \\ & 13 \text { to } 15 \end{aligned}$ | $\begin{array}{\|l} \hline \text { LX1, LX2 }=0 \text { V, } \\ \text { BST1, BST2 = VB } \\ \text { DRVL1, DRVL2-low to } \\ \text { DRVH1, DRVH2-on } \\ \hline \end{array}$ | 15 | 25 | 35 | ns |
|  |  |  |  | $\begin{aligned} & \text { LX1, LX2 = } 0 \text { V, } \\ & \text { BST1, BST2 = VB } \\ & \text { DRVH1, DRVH2-low to } \\ & \text { DRVL1, DRVL2-on } \end{aligned}$ | 35 | 50 | 65 | ns |
|  | BST diode voltage | $\mathrm{V}_{\mathrm{F}}$ | 1,12 | $\mathrm{I}_{\mathrm{F}}=10 \mathrm{~mA}$ | 0.75 | 0.85 | 0.95 | V |
|  | Bias current | $\mathrm{I}_{\text {BST }}$ | 1,12 | $\begin{aligned} & \text { LX1, LX2 = } 0 \mathrm{~V}, \\ & \text { BST1, BST2 }=5.2 \mathrm{~V} \end{aligned}$ | 11 | 15 | 22 | $\mu \mathrm{A}$ |

MB39A214A
Embedded in Tomorrow ${ }^{*}$

| Parameter |  | Symbol | Pin <br> No. | Condition | Value |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min |  |  | Typ | Max |  |
| Switching Frequency Control Block [FREQ] | Preset value 1 conditions |  | $V_{\text {FREQ1 }}$ | 7 | FREQ pin: GND connection | 0 | - | 0.2 | V |
|  | Preset value 2 conditions | $V_{\text {FREQ2 }}$ | 7 | FREQ pin: OPEN | 0.6 | - | 1.2 | V |
|  | Preset value 3 conditions | $V_{\text {FREQ3 }}$ | 7 | FREQ pin: VB connection | 2.4 | - | VB | V |
|  | FREQ pin output voltage | V FREQ | 7 | FREQ = OPEN | 0.63 | 0.9 | 1.17 | V |
| PFM Control Circuit Block [MODE] | PFM/PWM mode conditions PAF function negate | $V_{\text {PFM } 1}$ | 17 | MODE pin: GND connection | 0 | - | 0.2 | V |
|  | PFM/PWM mode conditions PAF function assert | VPFM2 | 17 | MODE pin : OPEN | 0.6 | - | 1.2 | V |
|  | PWM-fixed mode conditions | VPWM | 17 | MODE pin : VB connection | 4.6 | - | VB | V |
|  | PAF frequency | $\mathrm{f}_{\text {PAF }}$ | - | $\mathrm{Ta}=-30^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 30 | 45 | - | kHz |
|  | MODE pin voltage | $\mathrm{V}_{\text {Mode }}$ | 17 | MODE = OPEN | 0.63 | 0.9 | 1.17 | V |
| Enable Block [EN1, EN2] | ON condition | $\mathrm{V}_{\text {ON }}$ | 2, 11 | EN1, EN2 pins | 2.64 | - | - | V |
|  | OFF condition | VofF | 2,11 | EN1, EN2 pins | - | - | 0.66 | V |
|  | Hysteresis width | $\mathrm{V}_{\mathrm{H}}$ | 2, 11 | EN1, EN2 pins | - | $0.4{ }^{[1]}$ | - | V |
|  | Input current | $\mathrm{I}_{\text {EN }}$ | 2,11 | EN1, EN2 = 5V | 11 | 15 | 22 | $\mu \mathrm{A}$ |
| Power Supply Current | Standby current | Iccs | 19 | EN1, EN2 = 0V | - | 0 | 10 | $\mu \mathrm{A}$ |
|  | Power supply current during idle period | ICCl | 19 | LX1, LX2 = 0 V BST1, BST2 : <br> VB connection FB1, FB2 $=0.75 \mathrm{~V}$ | - | 600 | 860 | $\mu \mathrm{A}$ |
|  | Power supply current during operation | ICC2 | 19 | LX1, LX2 = 0V BST1, BST2 : <br> VB connection FB1, FB2 $=0.6 \mathrm{~V}$ | - | 1200 | 1700 | $\mu \mathrm{A}$ |

[1]: This parameter is not be specified. This should be used as a reference to support designing the circuits.

MB39A214A
Embedded in Tomorrow ${ }^{*}$

## 7. Typical Characteristics




DRVH1 minimum on time vs. Input voltage




DRVH2 minimum on time vs. Input voltage


DRVH2 minimum on time vs. Operating ambient temperature



## 8. Function

## Bottom detection comparator system for low output voltage ripple

The bottom detection comparator system for low output voltage ripple determines the ON time (ton) using the input voltage ( $\mathrm{V}_{\mathrm{in}}$ ) and output voltage ( $\mathrm{V}_{\text {Out }}$ ) to hold the ON state to a specified period. During the OFF period, the reference voltage (INTREF) is compared with the feedback voltage (FB) using the error comparator (Error Comp.). When the feedback voltage (FB) is below the reference voltage (INTREF), RS-FF is set and the ON period starts again. Switching is repeated as described above. Error Comp. is used to compare the reference voltage (INTREF) with the feedback voltage (FB) to control the off-duty condition in order to stabilize the output voltage.
This system adds the inductor current slope detected during the synchronous rectification period (toff) to the reference voltage (INTREF), and generates an output voltage slope during the OFF period, which is essential for the bottom detection comparator system, in the IC. This enables the stable control operations under the low output voltage ripple conditions.

## - Circuit diagram



- Waveforms


1. Bias Voltage Block (VB Reg.)

The 5.2 V (Typ) bias voltage is generated from the VCC pin voltage for the control, output, and boost circuits. When either or both of the EN1 pin (pin 2) and EN2 pin (pin 11) are set to the "H" level, the system is restored from the standby state to supply the bias voltage from the VB pin (pin 18).
2. ON/OFF Time Generator Block (ton Generator)

This block contains a capacitor for timing setting and a resistor for timing setting and generates ON time (ton) which depends on input voltage and output voltage. The switching frequency can be switched by setting the FREQ pin (pin 7) to any one of GND connection, OPEN, and VB connection. ON time for each CH is obtained from the following formula.
$<$ FREQ pin: GND connection>

$$
\begin{aligned}
& \text { toN1 }(\mathrm{ns})=\frac{\mathrm{V}_{\text {VOUT1 }}}{\mathrm{V}_{\mathrm{VIN}}} \times 4300 \quad\left(\mathrm{f}_{\text {OSC1 }} \doteqdot 230 \mathrm{kHz}\right) \\
& \text { toN2 }(\mathrm{ns})=\frac{\mathrm{V}_{\text {VOUT2 }}}{\mathrm{V}_{\mathrm{VIN}}} \times 3200 \quad\left(\mathrm{f}_{\mathrm{OSC} 2} \doteqdot 310 \mathrm{kHz}\right)
\end{aligned}
$$

<FREQ pin: OPEN>

$$
\begin{aligned}
& \mathrm{toN}(\mathrm{~ns})=\frac{\mathrm{V}_{\mathrm{Vout} 1}}{\mathrm{~V}_{\mathrm{VIN}}} \times 2100 \quad(\mathrm{fosc} \doteqdot 460 \mathrm{kHz}) \\
& \mathrm{toN}(\mathrm{~ns})=\frac{\mathrm{V}_{\text {VouT2 }}}{\mathrm{V}_{\mathrm{VIN}}} \times 1600 \quad(\mathrm{fosc} 2 \\
& \doteqdot 620 \mathrm{kHz})
\end{aligned}
$$

<FREQ pin: VB connection>

$$
\begin{aligned}
& \mathrm{toN}(\mathrm{~ns})=\frac{\mathrm{V}_{\text {vout1 }}}{\mathrm{V}_{\mathrm{VIN}}} \times 1300 \quad(\mathrm{fosc} \doteqdot 750 \mathrm{kHz}) \\
& \text { ton2 }(\mathrm{ns})=\frac{\mathrm{V}_{\text {Vout2 }}}{\mathrm{V}_{\mathrm{VIN}}} \times 1000 \quad(\mathrm{fosc} \doteqdot 1000 \mathrm{kHz})
\end{aligned}
$$

The switching frequency of CH 2 is set to 1.33 times that of CH 1 to prevent the beat by the frequency difference of channel to channel.

## 3. Output Block (DRV1, DRV2)

The output circuit is configured in CMOS type for both of the high-side and the low-side. It provides the 0.5 A (Typ) source current and 0.9 A (Typ) sink current, drive the external N -ch MOS FET. The output circuit of the high-side FET supplies the power from the boost circuit including the built-in boost diode. The output circuit of the low-side FET supplies the power from the VB pin. This circuit monitors the gate voltages of the high-side and low-side FETs. Until either FET is turned off, this circuit controls the ON timing of another FET, preventing the shoot-through current. The sink ON resistance of the output circuit is low $1 \Omega$ (Typ), improve the self turn on margin of low-side FET.

## 4. Starting sequence

When the EN1 pin (pin 2) or EN2 pin (pin 11) is set to the "H" level, the bias voltage is supplied from the VB pin. If the voltage of the VB pin exceeds the UVLO threshold voltage, the DC/DC converter starts operations and carries out the soft start. The soft start is a function used to prevent a rush current when the power is started.
Activating the soft start initiates charging of the capacitor connected to the CS1 pin (pin 5) and CS2 pin (pin 8) and inputs the lamp voltage to the error comparator (Error Comp.) of each channel. The DC/DC converter generates the output voltage according to that lamp voltage. This results in the soft start operation that does not depend on the output load. The over voltage protection (OVP) and under voltage protection (UVP) functions are disabled while the soft start is active.
<Timing chart>

5. DC/DC converter stop sequence (Discharge, standby)

When the EN1 pin (pin 2) or EN2 pin (pin 11) is set to the "L" level, the output capacitor is discharged using the discharge FET ( $\mathrm{RoN}_{\mathrm{ON}} \doteqdot 25 \Omega$ ) in the IC. If the voltage of the VOUT1 pin (pin 3) and VOUT2 pin (pin 10) is below 0.2 V (Typ) by discharging the output capacitor, the IC stops discharge operation. Further, if both the EN1 and EN2 pins are set to the "L" level, the IC also stops the output of the VB pin and enters the standby state after detecting UVLO. The current of the VCC pin (lvcc) is then $10 \mu \mathrm{~A}$ (Max).

6. Under Voltage Lockout Protection (UVLO)

The under voltage lockout protection (UVLO) protects ICs from malfunction and protects the system from destruction/deterioration, according to the reasons mentioned below.
■Transitional state when the bias voltage (VB) or the reference voltage (VREF) starts.
-Momentary decrease
To prevent such a malfunction, this function detects a voltage drop of the VB pin (pin 18) using the comparator (UVLO Comp.), and stops IC operations.
When the VB pin exceeds the threshold voltage of the under voltage lockout protection circuit, the system is restored.

## 7. Over Current Limitation (ILIM)

This function limits the output current when it has increased, and protects devices connected to the output. This function detects the inductor current $I_{L}$ from the electromotive force of the low-side FET on-resistance RoN, and compares this voltage with the $1 / 5$-time value of the voltage $\mathrm{V}_{\text {ILIM }}$ of the ILIM1 pin (pin 20) and ILIM2 pin (pin 16) on a cyclically, using ILIM Comp. Until this voltage falls below the over current limit value, the high-side FET is held in the off state. After the voltage has fallen below the limit value, the high-side FET is placed into the on state. This limits the lower bound of the inductor current and also restricts the over current. As a result, it becomes operation that the output voltage droops.
The over current limit value is set by connecting the resistor to the ILIM pin. The ILIM pin supplies the constant current of $5 \mu \mathrm{~A}$ (Typ). However, the current value has a temperature slope up to $4500 \mathrm{ppm} /{ }^{\circ} \mathrm{C}$ to compensate the temperature dependence characteristics of the low-side FET on-resistance.


MB39A214A
Embedded in Tomorrow
8. Over Voltage Protection (OVP)

This function stops the output voltage when the output voltage has increased, and protects devices connected to the output.
(1) Using OVP Comp, this function makes a comparison between the voltage which is 1.15 times (Typ) of the internal reference voltage INTREF1 and INTREF2 (0.7 V), and the feedback voltage for the FB1 pin (pin 4) and the FB2 pin (pin 9).
(2) If the feedback voltage mentioned in 1 detects the higher state by $15 \mu \mathrm{~s}$ (Typ) or more, the operations below will be performed.

- Set the RS latch.
- Set the DRVH1 pin (pin 24) and the DRVH2 pin (pin 13) to the "L" level.
- Set the DRVL1 pin (pin 22) and the DRVL2 pin (pin 15) to the "H" level.

These operations fix the high-side FET to the off state and the low-side FET to the on state for both channels of the DC/DC converter, and stops switching (latch stop). The over-voltage protection state can be cancelled by setting both the EN1pin (pin 2) and EN2 pin (pin 11) to the "L" level or reducing the VCC power once until the bias voltage (VB) falls below $\mathrm{V}_{\mathrm{THL}}$ of UVLO.

## <Timing chart>



MB39A214A
Embedded in Tomorrow ${ }^{*}$
9. Under Voltage Protection (UVP)

This function stops the output voltage when the output voltage has lowered, and protects devices connected to the output.
(1) Using UVP Comp, this function makes a comparison between the voltage which is 0.7 times (Typ) of the internal reference voltage REF1, REF2 ( 0.7 V ), and the feedback voltage for the FB1 pin (pin 4) and the FB2 pin (pin 9).
(2) If the feedback voltage mentioned in 1 detects the higher state by $150 \mu \mathrm{~s}$ (Typ) or more, the operations below will be performed.

- Set the RS latch.
- Set the DRVH1 pin (pin 24) and the DRVH2 pin (pin 13) to the "L" level.
- Set the DRVL1 pin (pin 22) and the DRVL2 pin (pin 15) to the "L" level.

These operations fix the high-side FET to the off state and the low-side FET to the off state for both channels of the DC/DC converter, and stops switching (latch stop). The discharge operation is then carried out to discharge the output capacitor (The discharge operation continues until the state of the under-voltage protection is released).
The under-voltage protection state can be cancelled by setting both the EN1 pin (pin 2) and EN2 pin (pin 11) to the "L" level or reducing the VCC power once until the bias voltage (VB) falls below $\mathrm{V}_{\text {THL }}$ of UVLO.


MB39A214A
10. Over Temperature Protection (OTP)

The over-temperature protection circuit block (OTP) provides a function that prevents the IC from a thermal destruction. If the junction temperature reaches $+150^{\circ} \mathrm{C}$, the DRVH1 pin (pin 24) and DRVH2 pin (pin 13) are set to the "L" level, and the DRVL1 pin (pin 22 ) and DRVL2 pin (pin 15) are set to the "L" level. This fixes the high-side and low-side FETs to the off-state, of both channels in the DC/DC converter, causing switching to be stopped. The discharge operation is then carried out to discharge the output capacitor (The discharge operation continues until the state of the over-temperature protection is released). If the junction temperature drops to $+125^{\circ} \mathrm{C}$, the soft start is reactivated. (Restored automatically.)
11. Operation mode

In the PWM-fixed mode, the system acts by the switching frequency specified with the FREQ pin regardless of the load. In the automatic PFM/PWM selection mode, the switching frequency is reduced at low load, for enhancing the conversion efficiency characteristics. This function detects 0 A of the inductor current from the electromotive force of the low-side FET ON resistance when the low-side FET ON state, and places the low-side FET into the off state. This idle period continued until the output voltage decreased, this results the switching frequency being reduced automatically depending on the load current when the inductor current is below the critical current. The system acts by the switching frequency specified with the FREQ pin, when the inductor current exceeds the critical current.
For Automatic PFM/PWM selection mode with PAF function, the switching frequency at low load is held to 30 kHz (Min) or more. The operation mode can be switched by setting the MODE pin (pin 17) to any one of GND connection, OPEN, and VB connection.

- PWM-fixed mode

- Automatic PFM/PWM selection mode

$X$ : Each channel number

MB39A214A
Embedded in Tomorrow ${ }^{*}$

## Enable function table

| EN1 pin | EN2 pin | DC/DC converter (CH1) | DC/DC converter (CH2) |
| :--- | :--- | :--- | :--- |
| L | L | OFF | OFF |
| H | L | ON | OFF |
| L | H | OFF | ON |
| H | H | ON | ON |

DC/DC Control mode function table

| MODE pin | DC/DC control |
| :--- | :--- |
| GND connection | Automatic PFM/PWM selection mode |
| OPEN | Automatic PFM/PWM selection mode with PAF function |
| VB connection | PWM-fixed mode |

## Switching frequency control function table

| FREQ pin | Switching frequency |
| :---: | :---: |
| GND connection | $\mathrm{fosc} 1^{\doteqdot} 230 \mathrm{kHz}$, fosc2 ${ }^{\text {¢ }}$ ¢ 310 kHz |
| OPEN | $\mathrm{fosc} \doteqdot 460 \mathrm{kHz}, \mathrm{fosc} \doteqdot 620 \mathrm{kHz}$ |
| VB connection | $\mathrm{fosc} 1 \doteqdot 750 \mathrm{kHz}, \mathrm{fosc}$ \% $\doteqdot 1000 \mathrm{kHz}$ |

## Protection function table

The following table shows the state of the VB pin (pin 18), the DRVH1 pin (pin 24), the DRVH2 pin (pin 13), the DRVL1 pin (pin 22), the DRVL2 pin (pin 15) when each protection function operates.

| Protection function | Detection condition | Output of each pin after detection |  |  | DC/DC output dropping operation |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | VB | DRVH1, DRVH2 | DRVL1, DRVL2 |  |
| Under Voltage Lockout Protection (UVLO) | $\mathrm{VB}<4.0 \mathrm{~V}$ | - | L | L | Natural electric discharge |
| Over-current limitation (ILIM) | $\begin{array}{\|l} \mathrm{V}_{\text {PGND }}-\mathrm{V}_{\mathrm{LL1} 1}, \mathrm{~V}_{\mathrm{LX} 2}> \\ \mathrm{V}_{\text {ILIM } 1}, \mathrm{~V}_{\text {ILIM } 2} \end{array}$ | 5.2 V | Switching | Switching | The voltage is dropped by the constant current |
| Over Voltage Protection (OVP) | $\mathrm{V}_{\mathrm{FB} 1}, \mathrm{~V}_{\mathrm{FB} 2}>$ <br> INTREF1, INTREF $2 \times 1.15$ <br> ( $15 \mu \mathrm{~s}$ or higher) | 5.2 V | L | H | 0 V clamping |
| Under Voltage Protection (UVP) | $\mathrm{V}_{\text {FB1 }}, \mathrm{V}_{\text {FB2 }}>$ <br> INTREF1, INTREF2×0.7 <br> ( $150 \mu \mathrm{~s}$ or higher) | 5.2 V | L | L | Electrical discharge by discharge function |
| Over Temperature Protection (OTP) | $\mathrm{Tj}>+150^{\circ} \mathrm{C}$ | 5.2 V | L | L | Electrical discharge by discharge function |
| Enable (EN) | EN1, EN2: H $\longrightarrow$ L <br> (VOUT1, $\mathrm{V}_{\text {OUT2 }}>0.2 \mathrm{~V}$ ) | 5.2 V | L | L | Electrical discharge by discharge function |

MB39A214A
Embedded in Tomorrow ${ }^{*}$

## 9. I/O Pin Equivalent Circuit Diagram



EN1, EN2 pins


FREQ pin


ILIM1, ILIM2 pins


MODE pin


VOUT1, VOUT2 pins



DRVH1, DRVH2, BST1, BST2, LX1, LX2 pins


## DRVL1, DRVL2 pins



VB pin


VCC pin


MB39A214A
Embedded in Tomorrow ${ }^{*}$

## 10. Example Application Circuit



## 11. Part List

| Component | Item | Specification | Vendor | Package | Part number | Remarks |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Q1 | N-ch FET | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=30 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=6.3 \mathrm{~A}, 8.6 \mathrm{~A}, \\ & \mathrm{R}_{\mathrm{ON}}=23 \mathrm{~m} \Omega, 13 \mathrm{~m} \Omega \end{aligned}$ | FAIRCHILD | SOP8 | FDS6982AS | DualType (2elements) |
| Q3 | N-ch FET | $\begin{aligned} & \mathrm{V}_{\mathrm{DS}}=30 \mathrm{~V}, \mathrm{I}_{\mathrm{D}}=6.3 \mathrm{~A}, 8.6 \mathrm{~A}, \\ & \mathrm{R}_{\mathrm{ON}}=23 \mathrm{~m} \Omega, 13 \mathrm{~m} \Omega \end{aligned}$ | FAIRCHILD | SOP8 | FDS6982AS | DualType (2elements) |
| L1 | Inductor | $1 \mu \mathrm{H}$ (18 A) | NEC TOKIN | - | MPC1055L1R0 |  |
| L2 | Inductor | $1.5 \mu \mathrm{H}(12.4 \mathrm{~A})$ | NEC TOKIN | - | MPLC1040L1R5 |  |
| C1-1 | Ceramic capacitor | $10 \mu \mathrm{~F}(25 \mathrm{~V})$ | MURATA | 3216 | GRM31CB31E106K |  |
| C1-2 | Ceramic capacitor | $10 \mu \mathrm{~F}(25 \mathrm{~V})$ | MURATA | 3216 | GRM31CB31E106K |  |
| C2-1 | POSCAP | $220 \mu \mathrm{~F}(2 \mathrm{~V})$ | SANYO | D case | 2TPLF220M6 |  |
| C2-3 | Ceramic capacitor | $1000 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H102K |  |
| C3-1 | Ceramic capacitor | $10 \mu \mathrm{~F}(25 \mathrm{~V})$ | MURATA | 3216 | GRM31CB31E106K |  |
| C3-2 | Ceramic capacitor | $10 \mu \mathrm{~F}(25 \mathrm{~V})$ | MURATA | 3216 | GRM31CB31E106K |  |
| C4-1 | POSCAP | $150 \mu \mathrm{~F}(6.3 \mathrm{~V})$ | SANYO | D case | 6TPL150MU |  |
| C4-3 | Ceramic capacitor | $1000 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H102K |  |
| C5 | Ceramic capacitor | $0.1 \mu \mathrm{~F}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H104K |  |
| C6 | Ceramic capacitor | $0.1 \mu \mathrm{~F}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H104K |  |
| C7 | Ceramic capacitor | $0.1 \mu \mathrm{~F}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H104K |  |
| C8 | Ceramic capacitor | $4.7 \mu \mathrm{~F}(16 \mathrm{~V})$ | TDK | 1608 | C1608JB1C475K |  |
| C12 | Ceramic capacitor | $3300 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H332K |  |
| C13 | Ceramic capacitor | $3300 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H332K |  |
| C14 | Ceramic capacitor | $1500 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H152K |  |
| C15 | Ceramic capacitor | $1500 \mathrm{pF}(50 \mathrm{~V})$ | TDK | 1608 | C1608JB1H152K |  |
| R1-1 | Resistor | $1.5 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P152D |  |
| R1-2 | Resistor | $27 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P273D |  |
| R2 | Resistor | $68 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P683D |  |
| R3-1 | Resistor | $4.3 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P432D |  |
| R3-2 | Resistor | $56 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P563D |  |
| R4 | Resistor | $39 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P393D |  |
| R5 | Resistor | $150 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P154D |  |
| R6 | Resistor | $150 \mathrm{k} \Omega$ | SSM | 1608 | RR0816P154D |  |
| R23 | Resistor | $1.8 \Omega$ | KOA | 1608 | RK73H1JTTD1R8F |  |
| R24 | Resistor | $1 \Omega$ | KOA | 1608 | RK73H1JTTD1R0F |  |

FAIRCHILD : Fairchild Semiconductor Corporation
SANYO : SANYO Electric Co., Ltd. / Panasonic
NEC TOKIN: NEC TOKIN Corporation
TDK : TDK Corporation
MURATA : Murata Manufacturing Co., Ltd.
SSM : SUSUMU Co., Ltd.

MB39A214A
Embedded in Tomorrow

## 12. Application Note

### 12.1 Setting Operating Conditions

## Setting output voltages

The output voltage can be set by adjusting the setting output voltage resistor ratio. Setting output voltage is calculated by the following formula.

$$
\mathrm{V}_{\text {OUTX }}=\frac{\mathrm{R} 1+\mathrm{R} 2}{\mathrm{R} 2} \times\left(0.6946+0.2667 \times \Delta \mathrm{I}_{\mathrm{L}} \times\left(1-\frac{2.8 \times 10^{-7}}{\text { toFF }}\right) \times R_{\text {ON_Sync }}\right)+\frac{\Delta \mathrm{V}_{\text {OUTx }}}{2}
$$

$$
\Delta V_{\text {OUTx }}=E S R \times \Delta \mathrm{I}_{\mathrm{L},} \Delta \mathrm{I}_{\mathrm{L}}=\frac{\mathrm{V}_{\text {IN }}-V_{\text {OUT }}}{\mathrm{L}} \times \frac{V_{\text {OUT }}}{V_{\text {IN }} \times f_{\text {OSC }}}, \text { toFF }=\frac{\left(\mathrm{V}_{\text {IN }}-V_{\text {OUTx }}\right)}{V_{\text {IN }} \times f_{\text {OSC }}}
$$

Voutx : Output setting voltage [V]
$\mathrm{V}_{\mathrm{IN}} \quad$ : Power supply voltage [V]
$\Delta \mathrm{V}_{\text {OUTX }} \quad$ : Output ripple voltage value [V]
toff : Off time [s]
Ron_Sync : ON resistance of low-side FET [ $\Omega$ ]
$\Delta \mathrm{I}_{\mathrm{L}} \quad:$ Ripple current peak-to-peak value of inductor $[\mathrm{A}]$
ESR : Series resistance element of output capacitor [ $\Omega$ ]
L : Inductor value [H]
fosc : Switching frequency [Hz]


The total resistor value ( $\mathrm{R} 1+\mathrm{R} 2$ ) of the setting output resistor should be selected up to $100 \mathrm{k} \Omega$.

## Minimum power supply voltage

The maximum on duty is limited by "the minimum off time (toffmin) that an IC holds without fail as a fixed value" and "the on time (ton) determined by the power voltage value and the output voltage setting value".
The ratio between the output voltage and the power voltage must be less than the maximum on duty.
The minimum power supply voltage that is required to sustain the output voltage can be calculated by the following formula.

$$
\begin{aligned}
& \mathrm{V}_{\text {IN_MIN }}=\frac{\left(\mathrm{V}_{\text {OUT }}+\text { loUt_MAX } \times(\text { RDC }+ \text { RON_Main })\right) \times \mathrm{V}_{\text {OUT }}}{\mathrm{V}_{\text {OUT }}-\left(\mathrm{V}_{\text {OUT }}+\text { loUT_MAX } \times(\text { RDC }+ \text { RON_Sync })\right) \times \text { toff_MIN } \times \text { fosc } \times 1.2} \\
& \text { VIN_MIN : Power supply voltage [V] } \\
& \text { Vout : Output setting voltage [V] } \\
& \text { lout_max : Maximum load current value [A] } \\
& \text { Ron_Main : ON resistance of high-side FET [ } \Omega \text { ] } \\
& \text { Ron_sync : ON resistance of low-side FET [ } \Omega \text { ] } \\
& \text { RDC : Series resistance of inductor [ } \Omega \text { ] } \\
& \text { fosc : Switching frequency setting value }[\mathrm{Hz}] \\
& \text { toff_min : Minimum off time (Maximum value) [s] } \\
& \text { (For the minimum off time, see "ON/OFF Time [Minimum OFF time ] " in " } 6 \text {. Electrical Characteristics".) }
\end{aligned}
$$

Use the smaller switching frequency setting in order to make the voltage output possible with the lower power voltage.

## Slope voltages

It is necessary to sustain the Slope voltage 15 mV or higher in order to obtain the stable switching cycle.
The Slope voltage can be calculated by the following formula.

$$
\begin{aligned}
\mathrm{V}_{\text {SIope }}= & \frac{\left(\mathrm{V}_{\text {IN }}-\mathrm{V}_{\text {OUT }}\right) \times \mathrm{V}_{\text {OUT }} \times \mathrm{R}_{\text {ON_Sync }}}{\mathrm{L} \times \mathrm{V}_{\text {IN }} \times f_{\text {OSC }}} \\
& \mathrm{V}_{\text {Slope }} \\
& : \text { Slope voltage }[\mathrm{V}] \\
\mathrm{V}_{\text {IN }} & : \text { Power supply voltage }[\mathrm{V}] \\
\mathrm{V}_{\text {OUT }} & : \text { Output setting voltage }[\mathrm{V}] \\
& \text { fosc } \\
& \text { : Switching frequency }[\mathrm{Hz}] \\
& \text { RON_Sync } \\
& \text { : ON resistance of low-side FET }[\Omega] \\
& : \text { Inductor value }[\mathrm{H}]
\end{aligned}
$$

MB39A214A
Embedded in Tomorrow

## Setting soft-start time

Calculate the soft-start time by the following formula.

$$
\mathrm{t}_{\mathrm{s}}=7 \times 10^{5} \times \mathrm{C}_{\mathrm{cs}}
$$

$\mathrm{t}_{\mathrm{s}} \quad$ : Soft-start time [s] (time until output reaches 100\%)
$\mathrm{C}_{\mathrm{cs}}$ : CS pin capacitor value $[\mathrm{F}]$

Calculate the delay time until the soft-start activation by the following formula.

$$
\mathrm{t}_{\mathrm{d}}=43 \times \mathrm{C}_{\mathrm{VB}}
$$

$$
\text { td } \quad \text { : VB voltage delay time (at } \mathrm{VIN}=12 \mathrm{~V} \text { ) [s] }
$$

CVB : VB pin capacitor value [F]

When activating the other in the state where a side channel has already been activated (UVLO release: VB output already), the delay time is hardly generated.


## Setting switching frequency

The switching frequency is set at the FREQ pin. As for the setting process, see the switching frequency control function table.

## Setting over current limitation

The over current limitation value can be set by adjusting the over current limitation setting resistor value connected to the ILIM pin. Calculate the resistor value by the following formula.

$$
R_{\mathrm{LIM}}=10^{6} \times \text { RoN_Sync } \times\left(\mathrm{I}_{\mathrm{LIM}}-\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}\right)
$$

| $R_{\text {LIM }}$ | : Over current limitation value setting resistor $[\Omega]$ |
| :--- | :--- |
| $\mathrm{I}_{\mathrm{LIM}}$ | : Over current limitation value $[\mathrm{A}]$ |
| $\Delta \mathrm{I}_{\mathrm{L}}$ | : Ripple current peak-to-peak value of inductor $[\mathrm{A}]$ |
| Ron_Sync | : ON resistance of low-side FET $[\Omega]$ |

$\square$


If the rate of inductor saturation current is small, the inductor value decreases and the ripple current of inductor increase when the over-current flows. At that time there is a possibility that the limited output current increases or is not limited, because the bottom of inductor current is detected. It is necessary to use the inductor that has enough large rate of inductor saturation current to prevent the overlap current.

The over current limit value is affected by ILIM pin source current and over current detection offset voltage in the IC except for the on resistance of the low-side FET and the inductor value. The variation of dropped over current limit value caused by IC characteristics is calculated by the following formula.

$$
\begin{aligned}
\Delta \operatorname{LIMM}= & \frac{2 \times 10^{-7} \times R_{\text {LIM }}+0.03}{\text { RON_Sync }} \\
& \Delta_{\text {LIM }} \quad: \text { The variation of dropped over current limit value }[\mathrm{A}] \\
& \text { RLIM } \quad \text { : Over current limitation value setting resistor }[\Omega] \\
& \text { RON_Sync }
\end{aligned}: \text { : ON resistance of low-side FET }[\Omega] .
$$



The over current detection value needs to set a sufficient margin against the maximum load current.

## Power dissipation and the thermal design

IC's loss increases, if IC is used under the high power supply voltage, high switching frequency, high load and high temperature. The IC internal loss can be calculated by the following formula.

```
PIC }=\mp@subsup{V}{\textrm{CC}}{}\times(\mp@subsup{I}{CC}{}+\mp@subsup{Q}{\mp@subsup{G}{_}{\primeTotal1 }}{}\times\mp@subsup{f}{\textrm{OSC1}}{}+\mp@subsup{Q}{\mp@subsup{\textrm{G}}{_}{\primeTota12}}{}\times\mp@subsup{f}{\textrm{OSC2}}{}
    PIC : IC internal loss [W]
    V
    Icc : Power supply current [A] (2 mA Max)
    QG_Total1 : Total quantity of charge for the high-side FET and the low-side FET of each CH1 [C]
    Q Q_Total2 : Total quantity of charge for the high-side FET and the low-side FET of each CH2 [C]
    fosc1 : CH1 switching frequency [Hz]
    fosc2 : CH2 switching frequency [Hz]
```

Calculate junction temperature ( Tj ) by the following formula.

$$
\mathrm{Tj}=\mathrm{Ta}+\theta_{\mathrm{ja}} \times \mathrm{P}_{\mathrm{I}}
$$

Tj : Junction temperature $\left[{ }^{\circ} \mathrm{C}\right]\left(+125^{\circ} \mathrm{C}\right.$ Max)
Ta : Ambient temperature $\left[{ }^{\circ} \mathrm{C}\right]$
Өja : TSSOP-24P Package thermal resistance $\left(+78^{\circ} \mathrm{C} / \mathrm{W}\right)$
Pıc : IC internal loss [W]

Handling of the pins when using a single channel
Although this device is a 2-channel DC/DC converter control IC, it is also able to be used as a 1-channel DC/DC converter by handling the pins of the unused channel as shown in the following diagram.


Note: $x$ is the unused channel number.

### 12.2 Selecting parts

## Selection of smoothing inductor

The inductor value selects the value that the ripple current peak-to-peak value of the inductor is $50 \%$ or less of the maximum load current as a rough standard. Calculate the inductor value in this case by the following formula.


L : Inductor value [H]
lout_max : Maximum load current [A]
LOR : Ripple current peak-to-peak value of inductor/Maximum load current ratio (=0.5)
$\mathrm{V}_{\mathrm{IN}} \quad$ : Power supply voltage [V]
Vout : Output setting voltage [V]
fosc : Switching frequency $[\mathrm{Hz}]$

It is necessary to calculate the maximum current value that flows to the inductor to judge whether the electric current that flows to the inductor is a rated value or less. Calculate the maximum current value of the inductor by the following formula.

$$
\mathrm{I}_{\mathrm{MAX}} \geq \text { lout_MAX }+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}
$$

$\mathrm{IL}_{\text {MAX }}$ : Maximum current value of inductor [ A ]
lout_max : Maximum load current [A]
$\Delta \mathrm{L}_{\mathrm{L}} \quad$ : Ripple current peak-to-peak value of inductor [A]
L : Inductor value [H]
VIN : Power supply voltage [V]
Vout : Output setting voltage [V]
fosc : Switching frequency $[\mathrm{Hz}]$


## Selection of switching FET

If selecting the high-side FET so that the value of the high-side FET conduction loss and the high-side FET switching loss is same, the loss is effectively decreased.
Confirm that the high-side FET loss is within the rating value.

```
PMainFET = Pron_Main + PSW_Main
PMainFET : High-side FET loss [W]
Pron_Main : High-side FET conduction loss [W]
PSw_Main : High-side FET switching loss [W]
```

High-side FET conduction loss

$$
\begin{aligned}
& P_{\text {RON_Main }}=\text { lout_Max }^{2} \times \frac{\text { V }_{\text {OUT }}}{V_{\text {IN }}} \times \text { RON_Main } \\
& \mathrm{P}_{\text {Ron_Main }} \text { : High-side FET conduction loss [W] } \\
& \text { lout_max : Maximum load current [A] } \\
& \mathrm{V}_{\mathrm{IN}} \quad \text { : Power supply voltage [V] } \\
& \text { Vout : Output voltage [V] } \\
& \text { Ron_Main : ON resistance of high-side FET [ } \Omega \text { ] }
\end{aligned}
$$

The high-side FET switching loss can be calculated roughly by the following formula.

$$
\mathrm{P}_{\text {SW_Main }} \doteqdot 1.56 \times \mathrm{V}_{\text {IN }} \times \text { fosc } \times \text { lout_MAX } \times \mathrm{Q}_{\text {sw }}
$$

Psw_Main : Switching loss [W]
$\mathrm{V}_{\mathrm{IN}} \quad$ : Power supply voltage [V]
fosc : Switching frequency $[\mathrm{Hz}]$
lout_max : Maximum load current [A]
Qsw : Amount of high-side FET gate switch electric charge [C]

MOSFET has a tendency where the gate drive loss increases because the lower drive voltage product has the bigger amount of gate electric charge $\left(\mathrm{Q}_{\mathrm{G}}\right)$. Normally, we recommend a 4 V drive product, however, the idle period at light load (both the high-side FET and the low-side FET is off-period) gets longer and the gate drive voltage of the high-side FET may decrease, in the automatic PFM/PWM selection mode. The voltage drops most at no-load mode. At this time, confirm that the boost voltage (voltage between BST-LX pins) is a big enough value for the gate threshold value voltage of the high-side FET.
If it is not enough, consider adding the boost diode, increasing the capacitor value of the boost capacitor or using a 2.5 V (or 1.8 V ) drive product to the high-side FET.

Select the ON resistance of low-side FET from the range below.

$$
\begin{aligned}
& R_{\text {ON_Sync }} \leq \frac{0.2}{\left(\mathrm{I}_{\mathrm{LIM}}-\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}\right)}, R_{\text {ON_Sync }} \leq \frac{0.1}{\Delta \mathrm{I}_{\mathrm{L}}}, R_{\mathrm{ON} \text { _Sync }} \geq \frac{0.015}{\Delta \mathrm{I}_{\mathrm{L}}} \\
& \text { Ron_sync : ON resistance of low-side FET [ } \Omega \text { ] } \\
& \Delta L_{\mathrm{L}} \quad: \text { Ripple current peak-to-peak value of inductor [A] } \\
& \text { ILIM: Over current detection value [A] }
\end{aligned}
$$

If the formula above has been already satisfied and then a low ON resistance FET as possible is used for the low-side FET, the loss is effectively decreased. Especially, it works dramatically in the low on duty mode. The loss of the low-side FET can be calculated by the following formula.

$$
\begin{aligned}
& \text { PSyncFET }=\text { PRON_Sync }=\text { lout_MAX }^{2} \times\left(1-\frac{\text { VOUT }}{\mathrm{V}_{\text {IN }}}\right) \times \text { RON_Sync } \\
& \mathrm{P}_{\text {SyncFET }} \text { : Low-side FET loss [W] } \\
& \mathrm{P}_{\text {RON_Sync }} \text { : Low-side FET conduction loss [W] } \\
& \text { lout_max : Maximum load current [A] } \\
& \mathrm{V}_{\mathrm{IN}} \quad \text { : Power supply voltage [V] } \\
& \text { Vout : Output voltage [V] } \\
& \text { Ron_Sync : ON resistance of low-side FET [ } \Omega \text { ] }
\end{aligned}
$$

Turn-on and turn-off voltage of the low-side FET is generally small and the switching loss is small enough to ignore, so that is omitted here.
Especially, when turning on the high-side FET under the high power supply voltage condition, the rush-current might be generated by according to self-turn-on of the low-side FET. The parasitic capacitor value of the low-side FET needs to satisfy the following conditions.

$$
\mathrm{V}_{\text {TH_Sync }}>\frac{\mathrm{C}_{\text {rss }}}{\mathrm{C}_{\mathrm{iss}}} \times \mathrm{V}_{\mathrm{IN}}
$$

| $\mathrm{V}_{\text {TH_Sync }}$ | : Threshold voltage of low-side FET [V] |
| :--- | :--- |
| $\mathrm{C}_{\text {rss }}$ | : Parasitic feedback capacitance of low-side FET [F] |
| $\mathrm{C}_{\mathrm{iss}}$ | : Parasitic input capacitance of low-side FET [F] |
| $\mathrm{V}_{\mathrm{IN}}$ | : Power supply voltage $[\mathrm{V}]$ |

Also approaches of adding a capacitor close between the gate source pins of the low-side FET or adding resistor between the BST pin and the boost capacitor, and so on are effective as a countermeasure of the self-turn-on(adding resistor between the BST pin and the boost capacitor is also effective to adjust turn-on time of the high-side FET).
This device monitors the gate voltage of the switching FET and optimizes the dead time. If the dumping resistor is inserted among DRVH, DRVL and the switching FET gate to adjust turn-on and turn-off time of the switching FET, this function might malfunction. In this device, resistor should not be connected among the DRVH pin, the DRVL pin of IC and the switching FET gate, and should be connected by low impedance as possible.

MB39A214A

The gate drive power of the switching FET is supplied from LDO (VB) of IC inside. Select switching FET so that the total amount of the switching FET electric charge for 2 channels (QG_Total1, QG_Total2) satisfies the following formula.

$$
I_{\text {VB_MAX }}>\mathrm{Q}_{\mathrm{G}_{-} \text {Total1 }} \times \mathrm{f}_{\mathrm{OSC} 1}+\mathrm{Q}_{\mathrm{G}_{-} \text {Tota12 }} \times \mathrm{f}_{\mathrm{OSC} 2}
$$

$I_{\text {VB_MAX }}$ : VB load current upper limit value (see the following graph) [A]
Q $_{\text {G_Total1 }}$ : Total quantity of charge for the high-side FET and the low-side FET of each CH 1 [C]
Q $_{\text {G_Total2 }}$ : Total quantity of charge for the high-side FET and the low-side FET of each CH 2 [C]
fosc1 : CH1Switching frequency $[\mathrm{Hz}]$
fosc2 : CH2 Switching frequency $[\mathrm{Hz}]$


Moreover, select the total quantity of the high-side FET electric charge as a guide that does not exceed the total quantity of the high-side FET electric charge upper limit value shown below.


Whether the mean current value that flows to switching FET is a rated value or less of switching FET is judged. Each rating value for the switching FET can be calculated roughly by the following formula.

```
ID_Main > IOUT_MAX × D
ID_Sync > lout_MAX × (1 - D)
    ID_Main : high-side FET drain current [A]
    ID_Sync : Low-side FET drain current [A]
    lout_max : Maximum load current [A]
    D : On-duty
V
    V DSs : Voltage between the high-side FET drain and source and the low-side FET drain and source [V]
    VIN : Power supply voltage [V]
```


## Selection of fly-back diode

This device is improved by adding the fly-back diode when the conversion efficiency improvement or the suppression of the low-side FET fever is desired, although those are unnecessary to execute normally. The effect is achieved in the condition where the switching frequency is high or output voltage is lower. Select schottky barrier diode (SBD) that the forward current is as small as possible. In this DC/DC control IC, the period for the electric current flow into fly-back diode is limited to dead time period because the synchronous rectification system is adopted. (as for the dead time, see "Output Block" in "6. Electrical Characteristics"). Each rating for the fly-back diode can be calculated by the following formula.

$$
\begin{aligned}
& I_{D} \geq \text { lout_MAX } \times \mathrm{fosc}^{\times} \times\left(\mathrm{t}_{\mathrm{D} 1}+\mathrm{t}_{\mathrm{D} 2}\right) \\
& \text { ID : Forward current rating of SBD }[A] \\
& \text { lout_max : Maximum load current [A] } \\
& \text { fosc : Switching frequency [ } \mathrm{Hz} \text { ] } \\
& t_{D 1}, t_{\mathrm{D} 2} \text { : Dead time [s] } \\
& \mathrm{I}_{\text {FSM }} \geq \text { lout_MAX }+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2} \\
& \text { IFSM : Peak forward surge current ratings of SBD [A] } \\
& \text { lout_max : Maximum load current [A] } \\
& \Delta \mathrm{I}_{\mathrm{L}} \quad \text { : Ripple current peak-to-peak value of inductor }[\mathrm{A}] \\
& \mathrm{V}_{\text {R_Fly }}>\mathrm{V}_{\mathrm{IN}} \\
& \text { VR_Fly : Reverse voltage of fly-back diode direct current [V] } \\
& \text { VIN : Power supply voltage [V] }
\end{aligned}
$$

## Selection of input capacitor

Select the input capacitor whose ESR is as small as possible. The ceramic capacitor is an ideal. Use the tantalum capacitor and the polymer capacitor of the low ESR when a mass capacitor is needed as the ceramic capacitor can not support.
The ripple voltage is generated in the power supply voltage by the switching operation of DC/DC. Calculate the lower bound of input capacitor according to an allowable ripple voltage. Calculate the ripple voltage of the power supply from the following formula.

$$
\Delta \mathrm{V}_{\mathbb{I N}}=\frac{\text { loUT_MAX }^{C_{\mathrm{IN}}} \times \frac{\mathrm{V}_{\text {OUT }}}{\mathrm{V}_{\mathrm{IN}} \times \mathrm{f}_{\text {OSC }}}+E S R \times\left(\text { lout_MAX }+\frac{\Delta \mathrm{I}_{\mathrm{L}}}{2}\right), ~\left(\frac{1}{2}\right)}{2}
$$

$\Delta \mathrm{V}_{\mathrm{IN}} \quad$ : Power supply ripple voltage peak-to-peak value [V]
lout_max : Maximum load current value [A]
$\mathrm{C}_{\mathrm{IN}} \quad$ : Input capacitor value [F]
$\mathrm{V}_{\mathrm{IN}} \quad$ : Power supply voltage [V]
Vout : Output setting voltage [V]
fosc : Switching frequency [Hz]
ESR : Series resistance component of input capacitor $[\Omega]$
$\Delta \mathrm{I}_{\mathrm{L}} \quad$ : Ripple current peak-to-peak value of inductor [A]

Capacitor has frequency characteristic, the temperature characteristic, and the bias voltage characteristic, etc. The effective capacitor value might become extremely small depending on the use conditions. Note the effective capacitor value in the use conditions.

Calculate ratings of the input capacitor by the following formula:

$$
\mathrm{V}_{\mathrm{CIN}}>\mathrm{V}_{\mathrm{IN}}
$$

$\mathrm{V}_{\mathrm{CIN}}$ : Withstand voltage of the input capacitor [V]
$\mathrm{V}_{\mathrm{IN}}$ : Power supply voltage [V]

$$
\operatorname{Irms} \geq \operatorname{lomAx} \times \frac{\sqrt{\mathrm{V}_{\text {OUT }} \times\left(\mathrm{V}_{\text {IN }}-\mathrm{V}_{\text {OUT }}\right)}}{\mathrm{V}_{\text {IN }}}
$$

Irms : Allowable ripple current of input capacitor (effective value) [A]
lomax : Maximum load current value [A]
$\mathrm{V}_{\mathrm{IN}} \quad$ : Power supply voltage [V]
Vout : Output setting voltage [V]

## Selection of output capacitor

A certain level of ESR is required for stable operation of this IC. Use a tantalum capacitor or polymer capacitor as the output capacitor. If using a ceramic capacitor with low ESR, a resistor should be connected in series with it to increase ESR equivalently. Calculate the output capacitor value by the following formula as a guide.

$$
\mathrm{C}_{\text {OUT }} \geq \frac{1}{4 \times \mathrm{f}_{\text {OSC }} \times \mathrm{ESR}}
$$

Cout : Output capacitor value [F]
fosc : Switching frequency $[\mathrm{Hz}]$

ESR : Series resistance of output capacitor $[\Omega]$

Moreover, the output capacitor values are also derived from the allowable amount of overshoot and undershoot. The following formula is represented as the worst condition in which the shift time for a sudden load change is 0 s. The output capacitor value allow a smaller amount than the value calculated by the following formula when a longer shift time.

$$
\begin{aligned}
& \mathrm{C}_{\text {OUT }} \geq \frac{\Delta \text { lout }^{2} \times \mathrm{L}}{2 \square \mathrm{~V}_{\text {OUT }} \times \Delta \mathrm{V}_{\text {OUT_OVER }}} \quad \text { Overshoot condition } \\
& \text { Cout } \geq \frac{\Delta \text { OUTT }^{2} \times L \times\left(V_{\text {OUT }}+V_{\text {IN }} \times \text { fosc } \times \text { toff_MIN }\right)}{2 \times V_{\text {OUT }} \times \Delta V_{\text {OUT_UNDER }} \times\left(V_{\text {IN }}-V_{\text {OUT }}-V_{\text {IN }} \times \text { fosc } \times \text { tofF_MIN }\right)} \quad \text { Undershoot condition } \\
& \text { Cout : Output capacitor value [F] } \\
& \Delta \mathrm{V}_{\text {OUt_OVER }} \text { : Allowable amount of output voltage overshoot [V] } \\
& \Delta \text { VOUT_UNDER } \text { : Allowable amount of output voltage undershoot [V] } \\
& \Delta \mathrm{l}_{\text {OUT }} \quad: \text { Current difference in sudden load change }[\mathrm{A}] \\
& \mathrm{L} \quad: \text { Inductor value }[\mathrm{H}] \\
& \mathrm{V}_{\mathrm{IN}} \quad \text { : Power supply voltage [V] } \\
& \text { Vout : Output setting voltage [V] } \\
& \text { fosc : Switching frequency }[\mathrm{Hz}] \\
& \text { toff_min : Minimum off time }
\end{aligned}
$$

When changing to no load suddenly, the output voltage is overshoot, however, the current sink is not executed in the mode other than PWM fix. As a result, the decrement of the output voltage might take a long time. This sometimes results in the stop mode because of the over voltage detection. In the mode other than PWM fix, select the capacitor value so that the overshoot value is set to the over voltage detection voltage value or less (115\% of the output setting voltage or less). The capacitor has frequency, operating temperature, and bias voltage characteristics, etc. Therefore, it must be noted that its effective capacitor value may be significantly smaller, depending on the use conditions.

Calculate each rating of the output capacitor by the following formula:

$$
\mathrm{V}_{\text {COUT }}>\mathrm{V}_{\text {OUT }}
$$

$\mathrm{V}_{\text {COUT }}$ : Withstand voltage of the output capacitor [V]
Vout : Output voltage [V]
$\mathrm{I}_{\text {RMS }} \geq \frac{\Delta \mathrm{I}_{\mathrm{L}}}{2 \sqrt{3}}$

IRMS : Allowable ripple current of output capacitor (effective value) [A]
$\Delta \mathrm{I}_{\mathrm{L}} \quad$ : Ripple current peak-to-peak value of inductor [A]

When connecting resistance in series configuration while a ceramic capacitor is in use, the resistor rating is calculated by the following formula.

$$
\mathrm{P}_{\mathrm{ESR}}>\frac{\mathrm{ESR} \times \Delta \mathrm{I}_{\mathrm{L}}{ }^{2}}{12}
$$

$P_{\text {ESR }} \quad$ : Power dissipation of resistor [W]
ESR : Resistor value [ $\Omega$ ]
$\Delta I_{\mathrm{L}} \quad$ : Ripple current peak-to-peak value of inductor [A]

## Selection of bootstrap capacitor

To drive the gate of high-side FET, the bootstrap capacitor must have enough stored charge. $0.1 \mu \mathrm{~F}$ is assumed to be standard, however, it is necessary to adjust it when the high-side FET $Q_{G}$ is big. Consider the capacitor value calculated by the following formula as the lowest value for the bootstrap capacitor and select a thing anymore.

$$
\mathrm{C}_{\mathrm{BST}} \geq 10 \times \mathrm{Q}_{\mathrm{G}}
$$

$\mathrm{C}_{\mathrm{BST}}$ : Bootstrap capacitor value [F]
$Q_{G} \quad:$ Total quantity of charge for the high-side FET gate [C]

Calculate ratings of the bootstrap capacitor by the following formula:

$$
\mathrm{V}_{\mathrm{CBST}}>\mathrm{V}_{\mathrm{B}}
$$

$\mathrm{V}_{\text {CBST }} \quad$ : Withstand voltage of the bootstrap capacitor [V]
VB : VB voltage [V]

## VB pin capacitor

$4.7 \mu \mathrm{~F}$ is assumed to be a standard, and when $\mathrm{Q}_{\mathrm{G}}$ of switching FET used is large, it is necessary to adjust it.
To suppress the ripple voltage by the switching FET gate drive, consider the capacitor value calculated by the following formula as the lowest value for VB capacitor and select a thing any more.

$$
\mathrm{C}_{\mathrm{VB}} \geq 50 \times \mathrm{Q}_{\mathrm{G}}
$$

$\mathrm{C}_{\text {VB }}$ : VB pin capacitor value [F]
$Q_{G} \quad:$ Total amount of gate charge of high-side FET and low-side switching FET for 2CH [C]

Calculate ratings of the VB pin capacitor by the following formula:

$$
\mathrm{V}_{\mathrm{CVB}}>\mathrm{V}_{\mathrm{B}}
$$

| $\mathrm{V}_{\mathrm{CVB}}$ | $:$ Withstand voltage of the VB pin capacitor [V] |
| :--- | :--- |
| $\mathrm{V}_{\mathrm{B}}$ | $:$ VB voltage $[\mathrm{V}]$ |

MB39A214A

## Layout

Consider the points listed below and do the layout design.
■Provide the ground plane as much as possible on the IC mounted face. Connect bypass capacitor connected with the VCC and VB pins, and GND pin of the switching system parts with switching system GND (PGND). Connect other GND connection pins with control system GND (AGND), and separate each GND, and try not to pass the heavy current path through the control system GND (AGND) as much as possible. In that case, connect control system GND (AGND) and switching system GND (PGND) at the single point of GND (PGND) directly below IC. Switching system parts are Input capacitor ( $\mathrm{C}_{\mathrm{IN}}$ ), Switching FET, fly-back diode (SBD), inductor (L) and Output capacitor (Cout).

■Connect the switching system parts as much as possible on the surface. Avoid the connection through the through-hole as much as possible.
■As for GND pins of the switching system parts, provide the through hole at the proximal place, and connect it with GND of internal layer.
■Pay the most attention to the loop composed of input capacitor ( $\mathrm{C}_{\mathrm{IN}}$ ), switching FET, and fly-back diode (SBD). Consider parts are disposed mutually to be near for making the current loop as small as possible.

■Place the bootstrap capacitor ( $\mathrm{C}_{\text {BST1 }}, \mathrm{C}_{\mathrm{BST}}$ ) proximal to BSTx and LXx pins of IC as much as possible.
■Connect the line to the LX pin proximal to the drain pin of low-side FET. Also large electric current flows momentary in this net. Wire the line of width of about 0.8 mm as standard, and as short as possible.
■Large electric current flows momentary in the net of DRVHx and DRVLx pins connected with the gate of switching FET. Wire the linewidth of about 0.8 mm to be a standard, as short as possible. Take special care about the line of the DRVLx pin, and wire the line as short as possible.

■By-pass capacitor ( $\mathrm{C}_{\mathrm{vcc}}, \mathrm{C}_{\mathrm{VB}}$ ) connected with VCC, and VB should be placed close to the pin as much as possible. Also connect the GND pin of the bypass capacitor with GND of internal layer in the proximal through-hole.
■Pull the feedback line to be connected to the VOUTx pin of the IC separately from near the output capacitor pin, whenever possible. Consider the line connected with VOUTx and FBx pins to keep away from a switching system parts as much as possible because it is sensitive to the noise.
Also, place the output voltage setting resistor connected to this line near IC, and try to shorten the line to the FBx pin. In addition, for the internal layer right under the component mounting place, provide the control system GND (AGND) of few ripple and few spike noises, or provide the ground plane of the power supply as much as possible.
Consider that the discharge current momentary flows into the VOUTx pin (about 200 mA at Vout $=5 \mathrm{~V}$ ) when the DC/DC operation stops, and then sustain the width for the feedback line.
There is leaked magnetic flux around the inductor or backside of place equipped with inductor. Line and parts sensitive to noise should be considered to be placed away from the inductor (or backside of place equipped with inductor).


## 13. Reference Data


*: EN2 Standby mode
Switching Frequency vs. Load Current


Output Voltage vs. Load Current


*: EN1 Standby mode Switching Frequency vs. Load Current


Output Voltage vs. Load Current


MB39A214A
Embedded in Tomorrow ${ }^{*}$

Output Ripple Waveform
Automatic PFM/PWM selection mode


Automatic PFM/PWM selection mode with PAF function


PWM-fixed mode



MB39A214A


MB39A214A
Embedded in Tomorrow ${ }^{*}$

Startup, Shutdown and Protection Function Operation Waveform

$\mathrm{VIN}=12 \mathrm{~V}$
IOUT1=7A(0.14 $\Omega$ )
IOUT2=7A(0.26 $)$
MODE=GND
FREQ=Open


Output Over Current Waveform
current


$\mathrm{VIN}=12 \mathrm{~V}$
IOUT1=7A(0.14 )
IOUT2=7A(0.26 $)$
MODE=GND
FREQ=Open

$\qquad$

## 14. Usage Precaution

Do not configure the IC over the maximum ratings.
If the IC is used over the maximum ratings, the LSI may be permanently damaged.
It is preferable for the device to normally operate within the recommended usage conditions. Usage outside of these conditions can have an adverse effect on the reliability of the LSI.

## Use the device within the recommended operating conditions.

The recommended values guarantee the normal LSI operation under the recommended operating conditions.
The electrical ratings are guaranteed when the device is used within the recommended operating conditions and under the conditions stated for each item.

## Printed circuit board ground lines should be set up with consideration for common impedance.

## Take appropriate measures against static electricity.

Containers for semiconductor materials should have anti-static protection or be made of conductive material.
After mounting, printed circuit boards should be stored and shipped in conductive bags or containers.
Work platforms, tools, and instruments should be properly grounded.
Working personnel should be grounded with resistance of $250 \mathrm{k} \Omega$ to $1 \mathrm{M} \Omega$ in serial body and ground.
Do not apply negative voltages.
The use of negative voltages below -0.3 V may make the parasitic transistor activated to the LSI , and can cause malfunctions.

MB39A214A
Embedded in Tomorrow

## 15. Ordering Information

| Part number | Package | Remarks |
| :---: | :--- | :---: |
| MB39A214APFT | 24-pin plastic TSSOP <br> (FPT-24P-M09) |  |

## 16. EV Board Ordering Information

| EV board number | EV board version No. | Remarks |
| :---: | :--- | :--- |
| MB39A214A-EVB-01 | MB39A214A-EVB-01 Rev. 1.0 | TSSOP-24 |

## 17. RoHS Compliance Information Of Lead (Pb) Free Version

The LSI products of Cypress with "E1" are compliant with RoHS Directive, and has observed the standard of lead, cadmium, mercury, Hexavalent chromium, polybrominated biphenyls (PBB), and polybrominated diphenyl ethers (PBDE). A product whose part number has trailing characters "E1" is RoHS compliant.

## 18. Marking Format (Lead Free Version)



MB39A214A

## 19. Labeling Sample (Lead free version)



MB39A214A
Embedded in Tomorrow ${ }^{-}$

## 20. MB39A214APFT Recommended Conditions of Moisture Sensitivity Level

[Cypress Recommended Mounting Conditions]

| Item | Condition |  |  |  |
| :--- | :--- | :--- | :---: | :---: |
| Mounting Method | IR (infrared reflow), warm air reflow |  |  |  |
| Mounting times | 2 times | Please use it within two years after manufacture. |  |  |
|  | Before opening | Less than 8 days |  |  |
|  | From opening to the 2nd reflow | Please process within 8 days <br> after baking $\left(125^{\circ} \mathrm{C} \pm 3^{\circ} \mathrm{C}, 24 \mathrm{H}+2 \mathrm{H} /-0 \mathrm{H}\right)$. <br> Baking can be performed up to two times. |  |  |
|  | When the storage period after <br> opening was exceeded | $5^{\circ} \mathrm{C}$ to $30^{\circ} \mathrm{C}, 70 \%$ RH or less (the lowest possible humidity) |  |  |
| Storage conditions |  |  |  |  |

## [Mounting Conditions]

1. IR (Infrared Reflow)

"M" rank : $250^{\circ} \mathrm{C}$ Max
(a) Temperature Increase gradient
(b) Preliminary heating
: Average $1^{\circ} \mathrm{C} / \mathrm{s}$ to $4^{\circ} \mathrm{C} / \mathrm{s}$
: Temperature $170^{\circ} \mathrm{C}$ to $190^{\circ} \mathrm{C}, 60 \mathrm{~s}$ to 180 s
(c) Temperature Increase gradient
: Average $1^{\circ} \mathrm{C} / \mathrm{s}$ to $4^{\circ} \mathrm{C} / \mathrm{s}$
(d) Peak temperature
: Temperature $250^{\circ} \mathrm{C}$ Max; $245^{\circ} \mathrm{C}$ or more, 10 s or less
(d') Main Heating
(e) Cooling
: Temperature $230^{\circ} \mathrm{C}$ or more, 40 s or less
or

Temperature $225^{\circ} \mathrm{C}$ or more, 60 s or less
or
Temperature $220^{\circ} \mathrm{C}$ or more, 80 s or less
: Natural cooling or forced cooling
Note: Temperature: the top of the package bod

MB39A214A
Embedded in Tomorrow
2. Manual soldering (partial heating method)

| Item | Condition |  |
| :--- | :--- | :--- |
| Storage period | Before opening | Within two years after manufacture |
|  | Between opening and mounting | Within two years after manufacture <br> (No need to control moisture during the storage period because <br> of the partial heating method.) |
|  | $5^{\circ} \mathrm{C}$ to $30^{\circ} \mathrm{C}, 70 \%$ RH or less (the lowest possible humidity) |  |
| Mounting conditions | Temperature at the tip of a soldering iron: $400^{\circ} \mathrm{C} \mathrm{Max}$ <br> Time: Five seconds or below per pin ${ }^{[1]}$ |  |

[1]: Make sure that the tip of a soldering iron does not come in contact with the package body.

MB39A214A
Embedded in Tomorrow ${ }^{*}$

## 21.Package Dimensions

| 24-pin plastic TSSOP | Lead pitch | 0.50 mm |
| :---: | :---: | :---: |
| Package width $\times$ <br> package length | $0.40 \mathrm{~mm} \times 6.50 \mathrm{~mm}$ |  |
| Lead shape | Gullwing |  |
|  |  |  |
| (FPT-24P-M09) |  |  |



MB39A214A
Embedded in Tomorrow

## 22. Major Changes

Spansion Publication Number: MB39A214A_DS405-00007

| Page | Section | Change Results |
| :---: | :---: | :---: |
| Revision 1.0 |  |  |
| - | - | Initial release |
| Revision 2.0 |  |  |
| 19 | FUNCTION <br> (9) Under Voltage Protection (UVP) | Corrected the timing chart as follows. Less than $15 \mu \mathrm{~s} \rightarrow$ Less than $150 \mu \mathrm{~s}$ |
| 24 | EXAMPLE APPLICATION CIRCUIT | Revised the figure. |
| 25, 26 | PART LIST | - Revised the symbol Q1, Q3, R1-1, R3-1 and R4 to R6. <br> - Added the symbol C14, C15, R23 and R24. <br> - Revised the company name. |
| $43 \sim 46$ | REFERENCE DATA | Revised the figure. |
| Revision 2.1 |  |  |
| - | - | Company name and layout design change |

Note: Please see "Document History" about later revised information.

MB39A214A
Embedded in Tomorrow

## Document History

Document Title: MB39A214A 2ch DC/DC Converter IC with PFM/ PWM Synchronous Rectification
Document Number: 002-08358

| Revision | ECN | Orig. of <br> Change | Submission <br> Date | Description of Change |
| :---: | :---: | :---: | :---: | :--- |
| $* *$ | - | TAOA | $01 / 31 / 2014$ | Migrated to Cypress and assigned document number 002-08358. <br> No change to document contents or format. |
| ${ }^{*}$ A | 5220356 | TAOA | $04 / 14 / 2016$ | Updated to Cypress format. |

MB39A214A

## Sales, Solutions, and Legal Information

## Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at Cypress Locations.

## Products

ARM ${ }^{\circledR}$ Cortex ${ }^{\circledR}$ Microcontrollers
Automotive
Clocks \& Buffers
Interface
Lighting \& Power Control
Memory
PSoC
Touch Sensing
USB Controllers
Wireless/RF
cypress.com/arm cypress.com/automotive
cypress.com/clocks
cypress.com/interface
cypress.com/powerpsoc
cypress.com/memory
cypress.com/psoc
cypress.com/touch
cypress.com/usb
cypress.com/wireless

PSoC ${ }^{\circledR}$ Solutions

psoc.cypress.com/solutions
PSoC 1 | PSoC 3 | PSoC 4 | PSoC 5LP
Cypress Developer Community
Community | Forums | Blogs | Video | Training
Technical Support
cypress.com/go/support

ARM and Cortex are the registered trademarks of ARM Limited in the EU and other countries.

[^0]
[^0]:    © Cypress Semiconductor Corporation, 2012-2016. This document is the property of Cypress Semiconductor Corporation and its subsidiaries, including Spansion LLC ("Cypress"). This document, including any software or firmware included or referenced in this document ("Software"), is owned by Cypress under the intellectual property laws and treaties of the United States and other countries worldwide. Cypress reserves all rights under such laws and treaties and does not, except as specifically stated in this paragraph, grant any license under its patents, copyrights, trademarks, or other intellectual property rights. If the Software is not accompanied by a license agreement and you do not otherwise have a written agreement with Cypress governing the use of the Software, then
     form, to modify and reproduce the Software solely for use with Cypress hardware products, only internally within your organization, and (b) to distribute the Software in binary code form externally to end users (either directly or indirectly through resellers and distributors), solely for use on Cypress hardware product units, and (2) under those claims of Cypress's patents that are infringed by the Software (as provided by Cypress, unmodified) to make, use, distribute, and import the Software solely for use with Cypress hardware products. Any other use, reproduction, modification, translation, or compilation of the Software is prohibited.

    TO THE EXTENT PERMITTED BY APPLICABLE LAW, CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS DOCUMENT OR ANY SOFTWARE OR ACCOMPANYING HARDWARE, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. To the extent permitted by applicable law, Cypress reserves the right to make changes to this document without further notice. Cypress does not assume any liability arising out of the application or use of any product or circuit described in this document. Any information provided in this document, including any sample design information or programming code, is provided only for reference purposes. It is
     are not designed, intended, or authorized for use as critical components in systems designed or intended for the operation of weapons, weapons systems, nuclear installations, life-support devices or systems, other medical devices or systems (including resuscitation equipment and surgical implants), pollution control or haz ardous substances management, or other uses where the failure of the device or system could cause personal injury, death, or property damage ("Unintended Uses"). A critical component is any component of a device or system whose failure to perform can be reasonably expected to cause the failure of the device or system, or to affect its safety or effectiveness. Cypress is not liable, in whole or in part, and you shall and hereby do release Cypress from any claim, damage, or other liability arising from or related to all Unintended Uses of Cypress products. You shall indemnify and hold Cypress harmless from and against all claims, costs, damages, and other liabilities, including claims for personal injury or death, arising from or related to any Unintended Uses of Cypress products.
    Cypress, the Cypress logo, Spansion, the Spansion logo, and combinations thereof, PSoC, CapSense, EZ-USB, F-RAM, and Traveo are trademarks or registered trademarks of Cypress in the United States and other countries. For a more complete list of Cypress trademarks, visit cypress.com. Other names and brands may be claimed as property of their respective owners.

